5	Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/685,659	FANG ET AL.	
Examiner	Art Unit	
Edna Wong	1753	

	SEARCHED		
Class	Subclass	Date	Examiner
205	300	2/7/2007	EW
205	302	2/7/2007	EW
205	123	2/7/2007	EW
205	157	2/7/2007	EW
205	758	2/7/2007	EW
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEAR( (INCLUDING SE	CH NOTES EARCH STRATEGY	)
	DATE	EXMR
Inventor Search	2/7/2007	EW
EAST	2/7/2007	EW
STN	2/7/2007	EW
Search Updated	5/26/2007	EW